Search Notes

Application/Control	No.
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09/616,013 Examiner

Edan Orgad

Applicant(s)/Patent under Reexamination

ISHIKAWA ET AL.

Art Unit

2684

	SEARCHED				
Class	Subclass	Date	Examiner		
455	434 436-442 450 432.1- 432.3	3/14/2006	EO		
455	435.1	3/14/2006	EO		
455	422.1	3/14/2006	EO		
455	452.1	3/14/2006	EO		
455	452.2	3/14/2006	EΟ		
375	130 356	3/14/2006	EO		
370	431 441 320	3/14/2006	EO		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
same as	above	3/14/2006	EO	
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
EAST 1.3, NPL: IEEE Xplore Discussed case with: Nay Maung (primary 455) Vo Nguyen (primary 455) Cong Le (primary 455)	3/2/2003	EO
Discussed case with: Nick Corsaro (primary 455) Lester Kincaid (SPE 455)	12/2/2004	EO
Inventor Name search	3/14/2006	EO
		